

Attorney Docket No.: SONY-50N3599



**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**  
Patent Application

Inventor(s): Peter Rae Shintani and Hirofumi Usui Group Art Unit:

Filed: 03/24/00

Examiner:

Serial No.:

Title: A METHOD OF SELECTING A PORTION OF A BLOCK OF DATA FOR DISPLAY BASED ON CHARACTERISTICS OF A DISPLAY DEVICE

Form 1449

**U.S. Patent Documents**

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
MWH	A	5,844,620	12/02/98	Coleman et al.	348	461	11/29/95
↓	B	5,909,212	06/01/99	Nishina et al.	345	327	07/11/97
	C	5,808,654	09/15/98	Loos	347	215	11/15/95
	D						
	E						
	F						

**Foreign Patent or Published Foreign Patent Application**

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	G							
	H							
	I							

**Other Documents**

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	J	
Examiner <i>Michael W. Hays</i>		Date Considered 2/13/03

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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**Patent Application****RECEIVED**  
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**Technology Center 2600**

Inventor(s): Shintani

Serial No.: 09/534,832

Group Art Unit: 2772

Filed: 3/24/00

Examiner: Not yet assigned

Title: A METHOD OF SELECTING A PORTION OF A BLOCK OF DATA FOR DISPLAY BASED  
ON CHARACTERISTICS OF A DISPLAY DEVICE**Form 1449****U.S. Patent Documents**

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
MWH	A	5,402,177	3/28/95	Maeshima et al	348	476	4/22/93
↓	B	5,384,600	1/24/95	Kaizaki et al	348	556	1/6/94
↓	C	5,587,928	12/24/96	Jones et al	364	514.A	5/13/94
↓	D	5,486,871	1/23/96	Filliman et al	348	558	5/29/91
↓	E	5,784,123	7/21/98	Yoshimi	348	556	5/8/96
↓	F	5,956,091	9/21/99	Drewery et al	348	445	3/18/97
	G						
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**Foreign Patent or Published Foreign Patent Application**

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	L							
	M							
	N							
	O							
	P							
	Q							

**Other Documents**

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	R	
	S	
	T	
Examiner	Michael L. Hogg	
	Date Considered	2/13/03

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